Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10629842	YOSHIKAWA ET AL.
Examiner	Art Unit
Kiss, Eric B	2192

SEARCHED					
Class		Subclass	Date	Examiner	
717	174		03/22/2007	EBK	
719	327		03/22/2007	EBK	
710	313		03/22/2007	EBK	

SEARCH NOTES				
Search Notes	Date	Examiner		
PALM Inventor search	03/22/2007	EBK		
EAST (USPAT; US-PGPUB; EPO; JPO; FPRS; DERWENT; IBM_TDB) (see search history printout)	03/22/2007	EBK		

INTERFERENCE SEARCH				
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